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| Notice of References Cited | Application/Control No. 09/727,424 | Applicant(s)/Patent Under Reexamination KAJI ET AL. | |
| | Examiner Aaron C Perez-Daple | Art Unit 2121 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-5,774,630 | 06-1998 | Lee et al. | 706/3 |
| | B | US-5,995,737 | 11-1999 | Bonissone et al. | 703/8 |
| | C | US-5,673,565 | 10-1997 | Jeong et al. | 62/80 |
| * | D | US-6,081,796 | 06-2000 | Takagi et al. | 706/1 |
| * | E | US-5,796,077 | 08-1998 | Jo, Sung-O | 219/497 |
| * | F | US-5,857,321 | 01-1999 | Rajamani et al. | 60/39.27 |
| * | G | US-6,314,412 B1 | 11-2001 | Yamaguchi et al. | 706/13 |
| * | H | US-4,510,565 A | 04-1985 | Dummermuth, Ernst | 700/7 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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